

ON Semiconductor®

## FDS6875

# Dual P-Channel 2.5V Specified PowerTrench™ MOSFET

## **General Description**

These P-Channel 2.5V specified MOSFETs are produced using ON Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

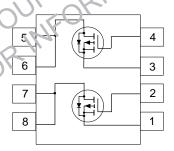
These devices are well suited for portable electronics applications: load switching and power management, battery charging and protection circuits.

### **Features**

- -6 A, -20 V.  $R_{DS(ON)} = 0.030 \,\Omega$  = -4.5 V,  $R_{DS(ON)} = 0.040 \,\Omega$   $U_{GS} = -2.5 \, V$ .
- Low gate charge (23r ypica
- High performation is the control of the performation of the control of the control
- High twee and culent handling uspability.





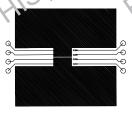


# Absolute Maximum Ratings 7. = 25°C unless otherwise noted

Symbol	Parameter	FDS6875	Units
LsS	Drain-Source Voltage	-20	V
GSS	Gate-Source Voltage	±8	V
)	Drain Current - Continuous (Note 1a)	-6	А
	- Pulsed	-20	
$P_{D}$	Power Dissipation for Dual Operation	2	W
	Power Dissipation for Single Operation (Note 1a)	1.6	
	(Note 1b)	1	
	(Note 1c)	0.9	
$\Gamma_{J}$ , $T_{STG}$	Operating and Storage Temperature Range	-55 to 150	°C
THERMA	L CHARACTERISTICS		
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	°C/W
R <sub>euc</sub>	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \ I_{D} = -250 \mu\text{A}$		-20			V
$\Delta$ BV <sub>DSS</sub> / $\Delta$ T <sub>J</sub>	Breakdown Voltage Temp. Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25 °C			-21		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, \ V_{GS} = 0 \text{ V}$				-1	μA
		Т	∫ = 55°C			-10	μA
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
GSSR	Gate - Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
ON CHARAC	CTERISTICS (Note 2)						ı
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$		-0.4	-0.8	-1.5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to 2	25 °C		a		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -4.5 \text{ V}, I_{D} = -6 \text{ A}$		7	0.02	0.03	-100
()		T			773	0.648	0,
		$V_{GS} = -2.5 \text{ V}, I_{D} = -5.3 \text{ A}$			0.032	0.04	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, \ V_{DS} = -5 \text{ V}$		Z <sub>0</sub>	5/1/4	-	Α
<b>9</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = -4.5 V, I <sub>D</sub> = -6 A		7	22		S
DYNAMIC (	HARACTERISTICS			2			l
C <sub>iss</sub>	Input Capacitance	$V_{D^c}$ $0 V_{GS}$ $V_{V}$			2250	N	pF
C <sub>oss</sub>	Output Capacitance	□ 0 MHΣ	$O$ , $\Box$	50	500	<u>),                                     </u>	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				200		pF
SWITCHING	CHARACTERISTICS (Note 2)	I SUL	1/2				,
t <sub>D(on)</sub>	Turn - On Delay Time	ν <sub>DS</sub> = -10 V, V <sub>0</sub> = -1 A	).\\(C)	<u>)                                    </u>	8	16	ns
ţ	Turn - On Rise Time	$V_{GEN} = 4.5 \text{ V}, P_{GEN} = 6 \Omega$	N		15	27	ns
t <sub>D(off)</sub>	Turn - Off Delay Ti	10°C 2			98	135	ns
t <sub>r</sub>	Turn - Off F Time	1,420,1			35	55	ns
Q <sub>g</sub>	Total Garage	$V_{DS} = -10 \text{ V}', I_{D} = 6 \text{ A},$			23	31	nC
$Q_{gs}$	Gate 'ource Cha e	V <sub>G°</sub> = -5 V			3.9		nC
$Q_{gd}$	C -D. 1 Charge	V),			5.5		nC
DRAIN-L U	RCE IODE CHARACTERISTICS AND MAXIM	UM RATINGS					
l <sub>s</sub>	ximum Continuous Drai: -Source Diode Forw	ard Current				-1.3	Α
$V_{SD}$	Drain Source Diode Forward Votege	$V_{GS} = 0 \text{ V}, I_{S} = -1.3 \text{ A} \text{ (Note 2)}$			-0.7	-1.2	V

<sup>1.</sup> R<sub>ax</sub> is the sum of the junction-to-case and case-to-, inbient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>axc</sub> is guaranteed by detign the R<sub>axc</sub> is determined by the usor's loard design.



a. 78°C/W on a 0.5 in² pad of 2oz copper.





Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2.0%.

### **Typical Electrical Characteristics**

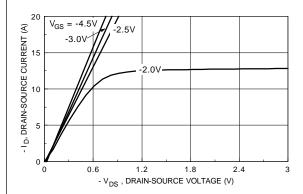
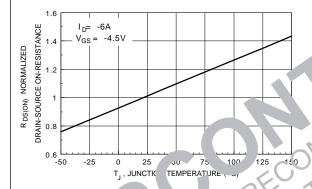


Figure 1. On-Region Characteristics.

Figure 2. Of kesic and Villation with Lind Current and Gate Voltage.



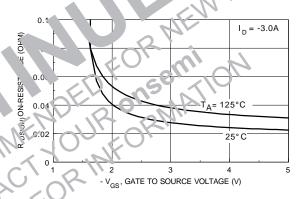
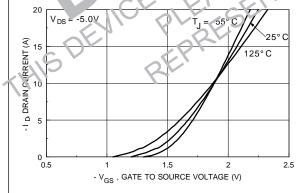


Figure 3. n-Resist ice Variation with neurature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



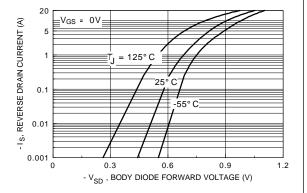
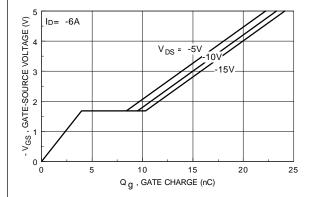


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage
Variation with Source Current
and Temperature.

### Typical Electrical Characteristics (continued)



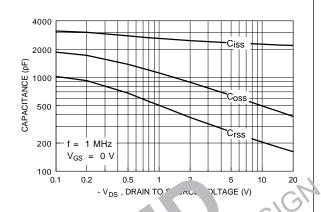
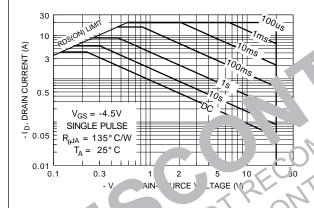
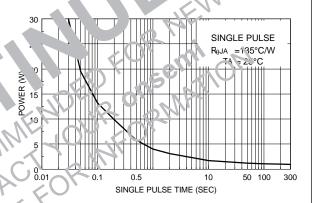


Figure 7. Gate Charge Characteristics.

Figure 8. Ca, 'ci' ...ce \ ...acteristics.





Jul 9. 'ax....um Safe Operating Area

Figure 10. Single Pulse Maximum Power Dissipation.

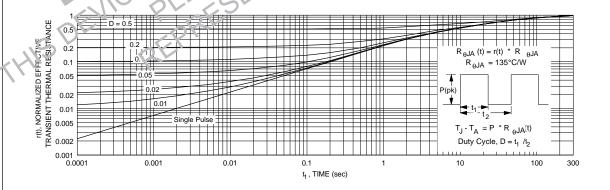


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.

Transient thermal response will change depending on the circuit board design.



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